

**Search Notes**

Application/Control No.

10/519,123

Examiner

HUYEN D. LE

Applicant(s)/Patent under  
Reexamination

CHARVIN ET AL.

Art Unit

2615

**SEARCHED**

Class	Subclass	Date	Examiner
381	312, 322, 326-328, 324, 330	3/27/2007	HL
381	331		HL
381	380-382		HL
600	25		HL
607	55-57		HL
181	129		HL
181	130		HL
181	135		HL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as above		3/27/2007	HL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Suhan Ni and Brian Ensey (Class 381)	3/27/2007	HL